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JUL 1 7 2006 (1)							Application Number			10/084.708			
SUPPLEMENTAL E							Confirmation No.:			6227			
INFORMATION DISCLOSURE							Filing	g Date	Fet	ruary	21, 2002		
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STATEMENT BY APPERANTS							Group Art Unit 2624				. ot ai		
							Examiner Name Duy M. Dang			1000			
Sheet	1	of 1									05058/16305		
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Examiner Initials	Cite #				PATEN	TEE		ISSUE DATE (mm/dd/yy)	CLA	ss	SUB CLASS	Filing Date if Appropriate	
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and	(1)	Japanese "Notice of Reasons for Rejection", dated April 11, 2006, for counterpart Japanese Patent Application No. 2004-162056; along with an English-language translation thereof											
	(2)	Japanese "Notice of Reasons for Rejection", dated April 11, 2006, for counterpart Japanese Patent Application No. 2004-162065; along with an English-language translation thereof											
mp	(3)	Japanese "Notice of Reasons for Rejection", dated May 16, 2006, for counterpart Japanese Patent Application No. 2004-162092; along with an English-language translation thereof											
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Examiner Signature

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Sheet 1

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANTS

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Complete if Known				
Application Number	10/084,708			
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First Inventor	Yoshikazu IKENOUE et al			
Group Art Unit	2624			
Examiner Name	Duy M. Dang			
Attorney Docket No.	05058/16305			

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